

MOC3031M MOC3032M MOC3033M MOC3041M MOC3042M MOC3043M

### **DESCRIPTION**

The MOC303XM and MOC304XM devices consist of a AlGaAs infrared emitting diode optically coupled to a monolithic silicon detector performing the function of a zero voltage crossing bilateral triac driver.

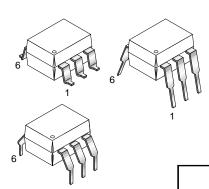
They are designed for use with a triac in the interface of logic systems to equipment powered from 115 VAC lines, such as teletypewriters, CRTs, solid-state relays, industrial controls, printers, motors, solenoids and consumer appliances, etc.

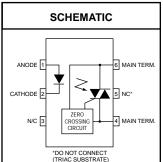
#### **FEATURES**

- Simplifies logic control of 115 VAC power
- · Zero voltage crossing
- dv/dt of 2000 V/μs typical, 1000 V/μs guaranteed
- VDE recognized (File # 94766)
   -ordering option V (e.g., MOC3043VM)

### **APPLICATIONS**

- Solenoid/valve controls
- Static power switches
- Temperature controls
- AC motor starters
- · Lighting controls
- · AC motor drives
- · E.M. contactors
- · Solid state relays





ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25°C unless otherwise noted)				
Parameters	Symbol	Device	Value	Units
TOTAL DEVICE	<b>-</b>	All	40 to 1450	°C
Storage Temperature	T <sub>STG</sub>	All	-40 to +150	٠.
Operating Temperature	T <sub>OPR</sub>	All	-40 to +85	°C
Lead Solder Temperature	T <sub>SOL</sub>	All	260 for 10 sec	°C
Junction Temperature Range	TJ	All	-40 to +100	°C
Isolation Surge Voltage <sup>(1)</sup> (peak AC voltage, 60Hz, 1 sec duration)	$V_{ISO}$	All	7500	Vac(pk)
Total Device Power Dissipation @ 25°C	Ъ	All	250	mW
Derate above 25°C	$P_{D}$	All	2.94	mW/°C
EMITTER		All	60	mA
Continuous Forward Current	l <sub>F</sub>	All	60	IIIA
Reverse Voltage	$V_{R}$	All	6	V
Total Power Dissipation 25°C Ambient	Б	All	120	mW
Derate above 25°C	$P_{D}$	All	1.41	mW/°C
DETECTOR	V	MOC3031M/2M/3M	250	V
Off-State Output Terminal Voltage	$V_{DRM}$	MOC3041M/2M/3M	400	V
Peak Repetitive Surge Current (PW = 100 μs, 120 pps)	I <sub>TSM</sub>	All	1	Α
Total Power Dissipation @ 25°C Ambient	D	All	150	mW
Derate above 25°C	P <sub>D</sub>	All	1.76	mW/°C

#### Note

1. Isolation surge voltage, V<sub>ISO</sub>, is an internal device dielectric breakdown rating. For this test, Pins 1 and 2 are common, and Pins 4, 5 and 6 are common.



MOC3031M	MOC3032M	MOC3033M	MOC3041M	MOC3042M	MOC3043M
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### **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C Unless otherwise specified)

INDIVIDUAL COMPONENT CHARACTERISTICS							
Parameters	Test Conditions	Symbol	Device	Min	Тур	Max	Units
EMITTER	J 20 m A		All		4.05	4.5	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
Input Forward Voltage	$I_F = 30 \text{ mA}$	V <sub>F</sub>	All		1.25	1.5	V
Reverse Leakage Current	V <sub>R</sub> = 6 V	I <sub>R</sub>	All		0.01	100	μA
DETECTOR							
Peak Blocking Current, Either Direction	Rated $V_{DRM}$ , $I_F = 0$ (note 1)	I <sub>DRM1</sub>	All			100	nA
Peak On-State Voltage, Either Direction	$I_{TM} = 100 \text{ mA peak}, I_F = 0$	$V_{TM}$	All		1.8	3	V
Critical Rate of Rise of Off-State Voltage	$I_F = 0$ (figure 9, note 3)	dv/dt	All	1000			V/µs

TRANSFER CHARACTERISTICS (T <sub>A</sub> = 25°C Unless otherwise specified.)							
DC Characteristics	Test Conditions	Symbol	Device	Min	Тур	Max	Units
LED Trigger Current			MOC3031M/MOC3041M			15	
	Main terminal voltage = 3V (note 2)	I <sub>FT</sub>	MOC3032M/MOC3042M			10	mA
			MOC3033M/MOC3043M			5	
Holding Current, Either Direction		I <sub>H</sub>	All		400		μΑ

ZERO CROSSING CHARACTERISTICS (T <sub>A</sub> = 25°C Unless otherwise specified.)							
Characteristics	Test Conditions Symbol Device Min Typ		Max	Units			
Inhibit Voltage	I <sub>F</sub> = rated I <sub>FT</sub> , MT1-MT2 voltage above	V <sub>IH</sub>	All	20	V		
""" voilage	which device will not trigger off-state	*IH		,	- "	1	
Leakage in Inhibited State	I <sub>F</sub> = rated I <sub>F</sub> , rated V <sub>DRM</sub> , off-state	I <sub>DRM2</sub> All 5		500	μΑ		

#### Note

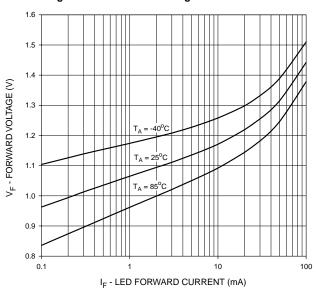
- 1. Test voltage must be applied within dv/dt rating.
- 2. All devices are guaranteed to trigger at an  $I_F$  value less than or equal to max  $I_{FT}$ . Therefore, recommended operating  $I_F$  lies between max  $I_{FT}$  (15 mA for MOC3031M & MOC3041M, 10 mA for MOC3032M & MOC3042M, 5 mA for MOC3033M & MOC3043M) and absolute max  $I_F$  (60 mA).
- 3. This is static dv/dt. See Figure 9 for test circuit. Commutating dv/dt is a function of the load-driving thyristor(s) only.



MOC3031M MOC3032M MOC3033M MOC3041M MOC3042M MOC3043M

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Figure 1. LED Forward Voltage vs. Forward Current



1F = 30mA TA = 25°C 400 400 -200 -600

Figure 2. On-State Characteristics

Figure 3. Trigger Current vs. Temperature

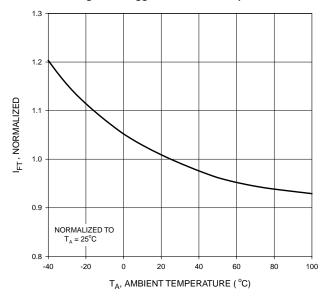
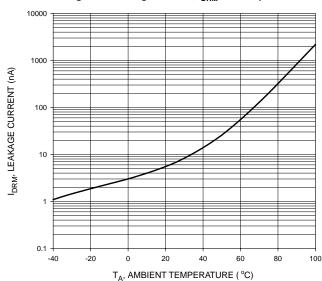


Figure 4. Leakage Current, IDRM vs. Temperature

 $V_{TM}$ , ON-STATE VOLTAGE (VOLTS)





MOC3031M MOC3032M MOC3033M MOC3041M MOC3042M MOC3043M

Figure 5. I<sub>DRM2</sub> - Leakage in Inhibit State vs. Temperature

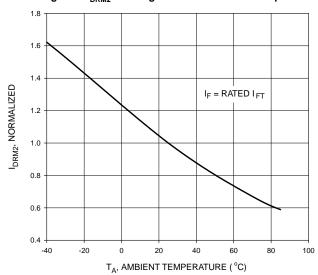


Figure 6. LED Current Required to Trigger vs. LED Pulse Width

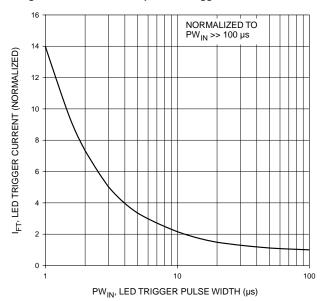


Figure 7. Holding Current,  $I_H$  vs. Temperature

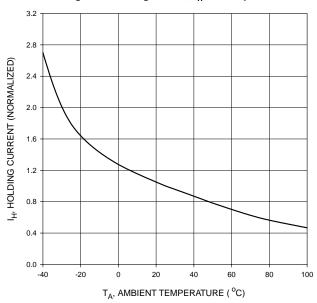
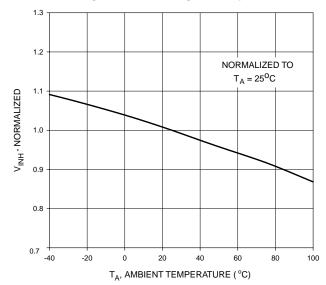


Figure 8. Inhibit Voltage vs. Temperature





MOC3031M MOC3032M MOC3033M MOC3041M MOC3042M MOC3043M

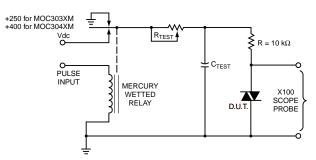


Figure 9. Static dv/dt Test Circuit

- The mercury wetted relay provides a high speed repeated pulse to the D.U.T.
- 100x scope probes are used, to allow high speeds and voltages.
- 3. The worst-case condition for static dv/dt is established by triggering the D.U.T. with a normal LED input current, then removing the current. The variable R<sub>TEST</sub> allows the dv/dt to be gradually increased until the D.U.T. continues to trigger in response to the applied voltage pulse, even after the LED current has been removed. The dv/dt is then decreased until the D.U.T. stops triggering. <sup>T</sup>RC is measured at this point and recorded.

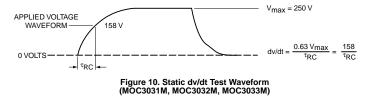


Figure 12. Hot-Line Switching Application Circuit (MOC3031M, MOC3032M, MOC3033M)

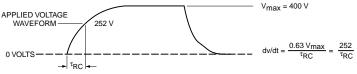


Figure 11. Static dv/dt Test Waveform (MOC3041M, MOC3042M, MOC3043M)

Typical circuit (Fig 12, 13) for use when hot line switching is required. In this circuit the "hot" side of the line is switched and the load connected to the cold or neutral side. The load may be connected to either the neutral or hot line.

 $R_{in}$  is calculated so that  $I_F$  is equal to the rated  $I_{FT}$  of the part, 5 mA for the MOC3033M and MOC3043M, 10 mA for the MOC3032M and MOC3042M, or 15 mA for the MOC3031M and MOC3041M. The 39 ohm resistor and 0.01  $\mu$ F capacitor are for snubbing of the triac and may or may not be necessary depending upon the particular triac and load used.

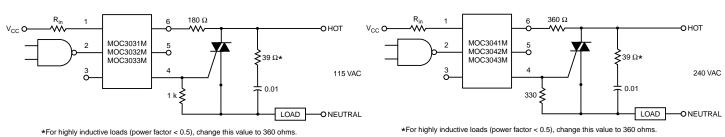


Figure 13. Hot-Line Switching Application Circuit (MOC3041M, MOC3042M, MOC3043M)

DS300256 8/06/01 5 OF 9 www.fairchildsemi.com



MOC3031M MOC3032M MOC3033M MOC3041M MOC3042M MOC3043M

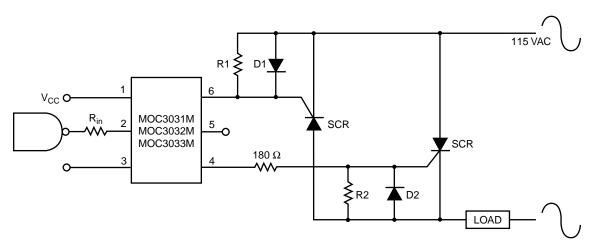


Figure 14. Inverse-Parallel SCR Driver Circuit (MOC3031M, MOC3032M, MOC3033M)

Suggested method of firing two, back-to-back SCR's with a Fairchild triac driver. Diodes can be 1N4001; resistors, R1 and R2, are optional 1 k ohm.

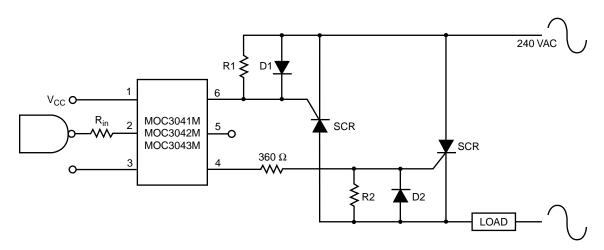


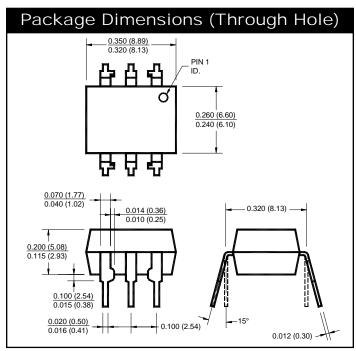
Figure 15. Inverse-Parallel SCR Driver Circuit (MOC3041M, MOC3042M, MOC3043M)

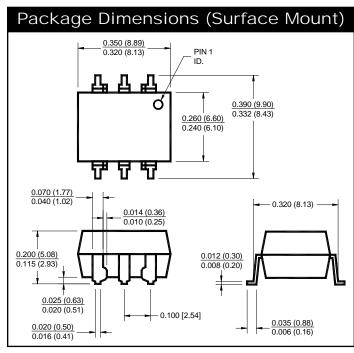
Suggested method of firing two, back-to-back SCR's with a Fairchild triac driver. Diodes can be 1N4001; resistors, R1 and R2, are optional 330 ohm.

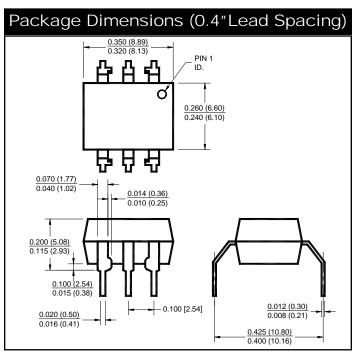
Note: This optoisolator should not be used to drive a load directly. It is intended to be a trigger device only.

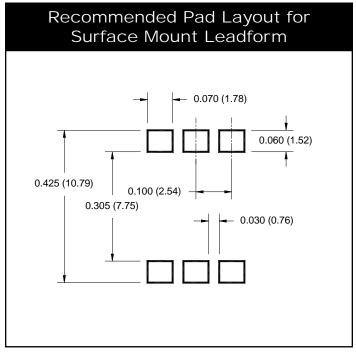


MOC3031M MOC3032M MOC3033M MOC3041M MOC3042M MOC3043M









### NOTE

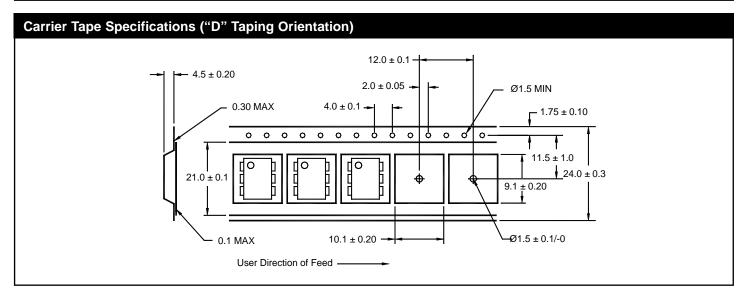
All dimensions are in inches (millimeters)



MOC3031M	MOC3032M	MOC3033M	MOC3041M	MOC3042M	MOC3043M

### ORDERING INFORMATION

Option	Order Entry Identifier	Description
S	S	Surface Mount Lead Bend
SR2	SR2	Surface Mount; Tape and reel
Т	Т	0.4" Lead Spacing
V	V	VDE 0884
TV	TV	VDE 0884, 0.4" Lead Spacing
SV	SV	VDE 0884, Surface Mount
SR2V	SR2V	VDE 0884, Surface Mount, Tape & Reel

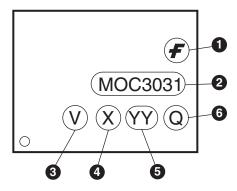


### **NOTE**

All dimensions are in inches (millimeters)

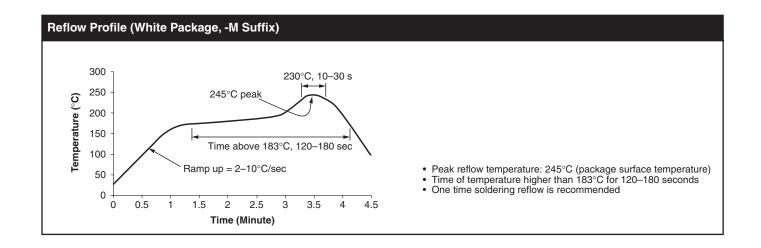


### **MARKING INFORMATION**



Definiti	Definitions					
1	Fairchild logo					
2	Device number					
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)					
4	One digit year code, e.g., '3'					
5	Two digit work week ranging from '01' to '53'					
6	Assembly package code					

\*Note – Parts that do not have the 'V' option (see definition 3 above) that are marked with date code '325' or earlier are marked in portrait format.



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EcoSPARK™	HiSeC™	MSX <sup>TM</sup>	QT Optoelectronics™	TinyLogic <sup>®</sup>
E <sup>2</sup> CMOS <sup>TM</sup>	I <sup>2</sup> C <sup>TM</sup>	MSXPro™	Quiet Series™	TINYOPTO™
EnSigna™	i-Lo <sup>TM</sup>	OCX <sup>TM</sup>	RapidConfigure™	TruTranslation™
FACT™	ImpliedDisconnect™	OCXPro™	RapidConnect™	UHC™
FACT Quiet Serie	es <sup>tm</sup>	OPTOLOGIC®	μSerDes™	UltraFET®
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Datasheet Identification	Product Status	Definition
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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Rev. I13